74ACT11175 QUADRUPLE D-TYPE FLIP-FLOP WITH CLEAR

DW OR N PACKAGE

SCAS089 - D3385, DECEMBER 1989 - REVISED APRIL 1993

- Inputs Are TTL-Voltage Compatible
- Buffered Clock and Direct Clear Inputs
- Applications Include: Buffer/Storage Registers, Shift Registers, Pattern Generators
- Fully-Buffered Outputs for Maximum Isolation From External Disturbances
- Flow-Through Architecture to Optimize PCB Layout
- Center-Pin V_{CC} and GND Configurations Minimize High-Speed Switching Noise
- EPIC[™] (Enhanced-Performance Implanted CMOS) 1-µm Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic Small-Outline Packages and Standard Plastic 300-mil DIPs

(TOP VIEW) 1Q 20 1Q 2Q 🛮 2 19 CLR 2Q [3 18 🛮 1D GND II 4 17 D GND [] 5 16 V_{CC} GND [] 6 15 V_{CC} GND ∏ 7 14**∏** 3D 3Q 🛮 8 13 **4**D 3Q [] 9 12 CLK 4Q **1** 10 11 **∏** 4 Q

description

This device contains six D-type flip-flops and is positive-edge-triggered with a direct clear input. Information at the D inputs meeting the setup time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive-going pulse. When the clock input is at either the high or low level, the D input signal has no effect at the output.

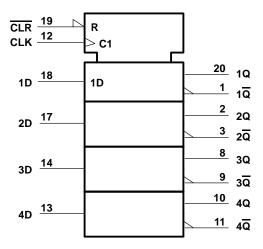
The 74AC11175 is characterized for operation from – 40°C to 85°C.

FUNCTION TABLE (each flip-flop)

INPUTS			OUTPUTS			
CLR	CLK	D	Q	Q		
L	Х	Χ	L	Н		
Н	\uparrow	Н	н	L		
Н	\uparrow	L	L	Н		
Н	L	Χ	Q_0	\overline{Q}_0		

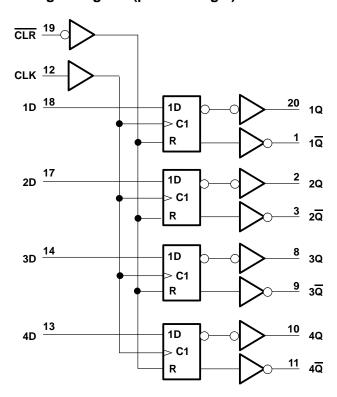
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logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}	0.5 V to 7 V
Input voltage range, V _I (see Note 1)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Output voltage range, V _O (see Note 1)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	± 20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC})	$\dots \dots \pm 50 \text{ mA}$
Continuous output current, I_O ($V_O = 0$ to V_{CC})	$\dots \dots \pm 50 \text{ mA}$
Continuous current through V _{CC} or GND	$\dots \dots \pm 200 \text{ mA}$
Storage temperature range	–65°C to 150°C

[‡]Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

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recommended operating conditions

		MIN	MAX	UNIT
VCC	Supply voltage	4.5	5.5	V
VIH	High-level input voltage	2		V
VIL	Low-level input voltage		0.8	V
VI	Input voltage	0	VCC	V
۷o	Output voltage	0	VCC	V
IOH	High-level output current		-24	mA
loL	Low-level output current		24	mA
Δt/Δν	Input transition rise or fall rate	0	10	ns/V
TA	Operating free-air temperature	- 40	85	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	vcc	T _A = 25°C			MIN	MAY	UNIT
PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	IVIIIN	MAX	UNII
	L 50 A		4.4			4.4		
	IOH = - 50 μA	5.5 V	5.4			5.4		
Voн	Jan - 24 mA	4.5 V	3.94			3.8		V
	I _{OH} = - 24 mA	5.5 V	4.94			4.8		
	$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V				3.85		
	Ι _{ΟL} = 50 μΑ				0.1		0.1	
	IOC = 20 μA	5.5 V			0.1		0.1	
VOL	la. 24 mA	4.5 V			0.36		0.44	V
	I _{OL} = 24 mA	5.5 V			0.36		0.44	
	$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V					1.65	
Ι _Ι	$V_I = V_{CC}$ or GND	5.5 V			± 0.1		± 1	μΑ
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			8		80	μΑ
∆l _{CC} ‡	One input at 3.4 V, Other inputs at GND or V _{CC}	5.5 V			0.9		1	mA
C _i	$V_I = V_{CC}$ or GND	5 V		4				pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

			T _A = :	25°C	MIN	MAX	UNIT
			MIN	MAX	IVIIIV	IVIAA	UNIT
fclock	Clock frequency		0	100	0	100	MHz
District dissertion	Pulse duration	CLR low	5		5		ns
t _W	ruise duration	CLK high or low	5		5		
	Catura tima hafara CLKA	Data	5		5		20
t _{su} Se	Setup time before CLK↑ CLR inactive		5		5		ns
th	Hold time, data after CLK↑		0.5		0.5	·	ns



[‡] This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

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switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	T _A = 25°C			MIN	MAX	UNIT
FARAIVIETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	IVIIIV	IVIAA	UNIT
fmax			100	130		100		MHz
t	CLB	Any Q	2.5	5.4	7.4	2.5	8.1	ne
^t PLH	CLR	Any Q	2.5	5.4	7.4	2.5	8.1	ns
+ =		Any Q	3.1	7.6	9.9	3.1	10.9	
^t PHL	CLR	Any Q	3.1	7.6	9.9	3.1	10.9	ns
+ =	CLK	Any Q	3	5.3	6.9	3	7.5	20
^t PLH	CLK	Any Q	3	5.3	6.9	3	7.5	ns
^t PHL	CLK	Any Q	3.3	7.2	9.2	3.3	10.1	ns
	CLK	Any Q	3.3	7.2	9.2	3.3	10.1	115

operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

	PARAMETER			UNIT
Г	C _{pd} Power dissipation capacitance	$C_L = 50 \text{ pF}, \qquad f = 1 \text{ MHz}$	42	pF

PARAMETER MEASUREMENT INFORMATION **From Output Under Test** tw 3 V $C_L = 50 pF$ 500 Ω (see Note A) Input 1.5 V **VOLTAGE WAVEFORMS LOAD CIRCUIT** 3 V Input 1.5 V (see Note B) 0 V **Timing Input** ^tPHL **tPLH** (see Note B) ۷он 0 V In-Phase 50% V_{CC} 50% V_{CC} th Output v_{OL} ^tPLH 1.5 V tPHL ─◀ **Data Input** 0 V VOH **Out-of-Phase** 50% V_{CC} 50% V_{CC} Output

NOTES: A. C_L includes probe and jig capacitance.

VOLTAGE WAVEFORMS

B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \ \Omega$, $t_f = 3 \ ns$, $t_f = 3 \ ns$.

VOL

VOLTAGE WAVEFORMS

 $\ensuremath{\text{C}}.$ The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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